

Notice of References Cited	Application/Control No. 10/567,211		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner TUNG X. LE		Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0012347	01-2004	Ribarich, Thomas J.	315/291
*	C	US-2003/0107332	06-2003	Newman et al.	315/307
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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